



Elliott Laboratories Inc.
www.elliottlabs.com

684 West Maude Avenue
Sunnyvale, CA 94085-3518

408-245-7800 Phone
408-245-3499 Fax

American TCB

September 13, 2005

RE: FCC ID: P65ALR9800_ATCB002755

Attention: Dennis Ward

Please find our responses to your comments on this Application below:

1. Please note that the operational description heading says it is for the ALR-9800. However, further in the description it states the document is for the ALR-9780. Please explain. Are these the same device being discussed?

Noted, a revised operational description has been uploaded.

2. Please note that MPE is a separate exhibit which is to be uploaded to the FCC server. Please provide a separate MPE report for this application.

Noted. An MPE Report has been uploaded to the RF Exposure Exhibit. Additionally a revised report has been uploaded.

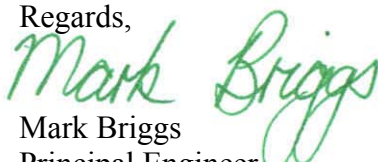
3. Please note that the report on page 24 (pdf page number) says the device was modified as follows:

"Cut TP1 & TP3 for 400 MHz reading."

The test being performed was a radiated emissions test to FCC class A. Were they cut for the purpose of making the device compliant? If so, even though this is a class A digital device test situation, this would still have to be done on all production devices. In this case some confirmation from the manufacturer that this modification will be implemented in production should be provided or at least kept on file in case questions arise. If this modification was performed prior to transmitter testing then it is not know if this modification is or is not needed for compliance. Was this modification done prior to transmitter testing? If so, please provide evidence that the manufacturer will implement this modification or alternately please provide evidence that the transmitter portion is compliant without the modification. If this was not done for compliance reasons, please explain why the traces were cut.

Yes the traces were cut for the purpose of making the device compliant. The manufacturer states that this modification will be applied to all production devices.

Regards,


Mark Briggs
Principal Engineer